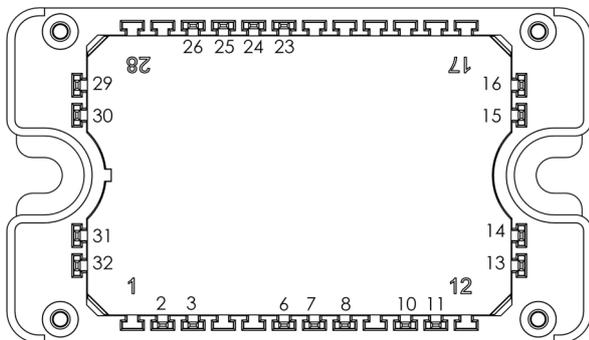
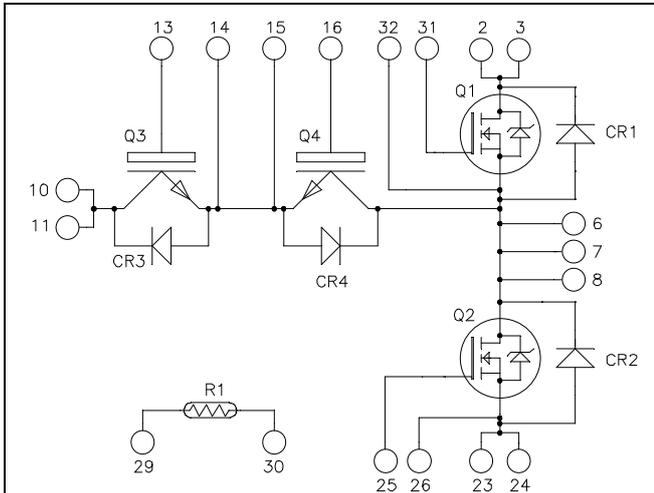


**Phase Leg & Dual Common Emitter
Power Module**



All multiple inputs and outputs must be shorted together
10/11 ; 23/24 ; 2/3 ; ...

SiC MOSFET (Q1, Q2):

$V_{CES} = 1200V$; $R_{DS(on)} = 98m\Omega$ max @ $T_j = 25^\circ C$

Trench & Field Stop IGBT3 (Q3, Q4):

$V_{CES} = 600V$; $I_C = 20A$ @ $T_c = 100^\circ C$

Application

- Solar converter
- Uninterruptible Power Supplies

Features

- **Q1, Q2 SiC Power MOSFET**
 - Low $R_{DS(on)}$
 - High temperature performance
- **Q3, Q4 Trench + field Stop IGBT3**
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 20 kHz
- **SiC Schottky Diode (CR1 to CR4)**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF

- Kelvin emitter for easy drive
- Very low stray inductance
- AlN substrate for improved thermal performance
- Internal thermistor for temperature monitoring

Benefits

- Stable temperature behavior
- Very rugged
- Solderable terminals for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25^\circ C$ unless otherwise specified

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.
See application note APT0502 on www.microsemi.com

1. SiC MOSFET characteristics (Per MOSFET)
Absolute maximum ratings

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>
V_{DSS}	Drain - Source Voltage	1200	V
I_D	Continuous Drain Current	$T_c = 25^\circ\text{C}$	26
		$T_c = 80^\circ\text{C}$	20
I_{DM}	Pulsed Drain current	55	A
V_{GS}	Gate - Source Voltage	-10/+25	V
$R_{DS(on)}$	Drain - Source ON Resistance	98	m Ω
P_D	Power Dissipation	$T_c = 25^\circ\text{C}$	125
			W

Electrical Characteristics

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 1200V$			100	μA
$R_{DS(on)}$	Drain - Source on Resistance	$V_{GS} = 20V$ $I_D = 20A$	$T_j = 25^\circ\text{C}$	80	98	m Ω
			$T_j = 150^\circ\text{C}$	153		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 5mA$	2.4	3		V
I_{GSS}	Gate - Source Leakage Current	$V_{GS} = 20V, V_{DS} = 0V$			250	nA

Dynamic Characteristics

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
C_{iss}	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 1000V$ $f = 1MHz$		950		pF
C_{oss}	Output Capacitance			80		
C_{riss}	Reverse Transfer Capacitance			7.6		
Q_g	Total gate Charge	$V_{GE} = 20V$		62		nC
Q_{gs}	Gate - Source Charge	$V_{Bus} = 800V$		15		
Q_{gd}	Gate - Drain Charge	$I_D = 20A$		23		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -5/+20V$ $V_{Bus} = 800V$ $I_D = 20A$ $R_L = 40\Omega; R_G = 50\Omega$		12		ns
T_r	Rise Time			14		
$T_{d(off)}$	Turn-off Delay Time			23		
T_f	Fall Time			18		
E_{on}	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$ $I_D = 20A$ $R_G = 50\Omega$	$T_j = 150^\circ\text{C}$	0.45		mJ
E_{off}	Turn off Energy			$T_j = 150^\circ\text{C}$	0.25	
R_{thJC}	Junction to Case Thermal Resistance				1	$^\circ\text{C}/\text{W}$

SiC diode ratings and characteristics (CR1 & CR2) (per diode)

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V _{RRM}	Peak Repetitive Reverse Voltage				1200	V
I _{RM}	Reverse Leakage Current	V _R = 1200V	T _j = 25°C	10	200	μA
			T _j = 175°C	500		
I _F	DC Forward Current		T _c = 100°C	10		A
V _F	Diode Forward Voltage	I _F = 10A	T _j = 25°C	1.5	1.8	V
			T _j = 175°C	2.3		
Q _C	Total Capacitive Charge	I _F = 10A, V _R = 600V di/dt = 500A/μs		120		nC
C	Total Capacitance	f = 1MHz, V _R = 200V		115		pF
		f = 1MHz, V _R = 400V		85		
R _{thJC}	Junction to Case Thermal Resistance				1.1	°C/W

2. Trench & Field Stop IGBT3 (per IGBT)
Absolute maximum ratings

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>
V _{CES}	Collector - Emitter Voltage	600	V
I _C	Continuous Collector Current	T _C = 25°C	37
		T _C = 100°C	20
I _{CM}	Pulsed Collector Current	T _C = 25°C	40
V _{GE}	Gate - Emitter Voltage	±20	V
P _D	Power Dissipation	T _C = 25°C	78
RBSOA	Reverse Bias Safe Operating Area	T _J = 150°C	40A @ 550V

Electrical Characteristics

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
I _{CES}	Zero Gate Voltage Collector Current	V _{GE} = 0V, V _{CE} = 600V			250	μA
V _{CE(sat)}	Collector Emitter Saturation Voltage	V _{GE} = 15V I _C = 20A	T _j = 25°C	1.5	1.9	V
			T _j = 150°C	1.7		
V _{GE(th)}	Gate Threshold Voltage	V _{GE} = V _{CE} , I _C = 300μA		5.0	5.8	6.5
I _{GES}	Gate - Emitter Leakage Current	V _{GE} = 20V, V _{CE} = 0V			300	nA

Dynamic Characteristics

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
C_{ies}	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1MHz$		1100		pF
C_{oes}	Output Capacitance			70		
C_{res}	Reverse Transfer Capacitance			35		
Q_G	Gate charge	$V_{GE} = \pm 15V, I_C = 20A$ $V_{CE} = 300V$		200		nC
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C) $V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 20A$ $R_G = 12\Omega$		110		ns
T_r	Rise Time			45		
$T_{d(off)}$	Turn-off Delay Time			200		
T_f	Fall Time			40		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 20A$ $R_G = 12\Omega$		120		ns
T_r	Rise Time			50		
$T_{d(off)}$	Turn-off Delay Time			250		
T_f	Fall Time			60		
E_{on}	Turn-on Switching Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 20A$ $R_G = 12\Omega$	$T_j = 25^\circ C$	0.11		mJ
			$T_j = 150^\circ C$	0.2		
E_{off}	Turn-off Switching Energy		$T_j = 25^\circ C$	0.5		mJ
			$T_j = 150^\circ C$	0.7		
I_{sc}	Short Circuit data	$V_{GE} \leq 15V ; V_{Bus} = 360V$ $t_p \leq 10\mu s ; T_j = 150^\circ C$		100		A
R_{thJC}	Junction to Case Thermal Resistance				1.92	°C/W

3. SiC diode ratings and characteristics (CR3 & CR4) (per diode)

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V_{RRM}	Peak Repetitive Reverse Voltage				600	V
I_{RM}	Reverse Leakage Current	$V_R = 600V$	$T_j = 25^\circ C$	10	60	μA
			$T_j = 175^\circ C$	20	300	
I_F	DC Forward Current			10		A
V_F	Diode Forward Voltage	$I_F = 10A$	$T_j = 25^\circ C$	1.6	1.8	V
			$T_j = 175^\circ C$	2	2.4	
Q_C	Total Capacitive Charge	$I_F = 10A, V_R = 600V$ $di/dt = 500A/\mu s$		28		nC
C	Total Capacitance	$f = 1MHz, V_R = 200V$		65		pF
		$f = 1MHz, V_R = 400V$		50		
R_{thJC}	Junction to Case Thermal Resistance				2.2	°C/W

4. Temperature sensor NTC

Symbol	Characteristic	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C		22		kΩ
ΔR ₂₅ /R ₂₅	Resistance tolerance			5	%
ΔB/B	Beta tolerance			3	
B _{25/100}	T ₂₅ = 298.16 K		3980		K

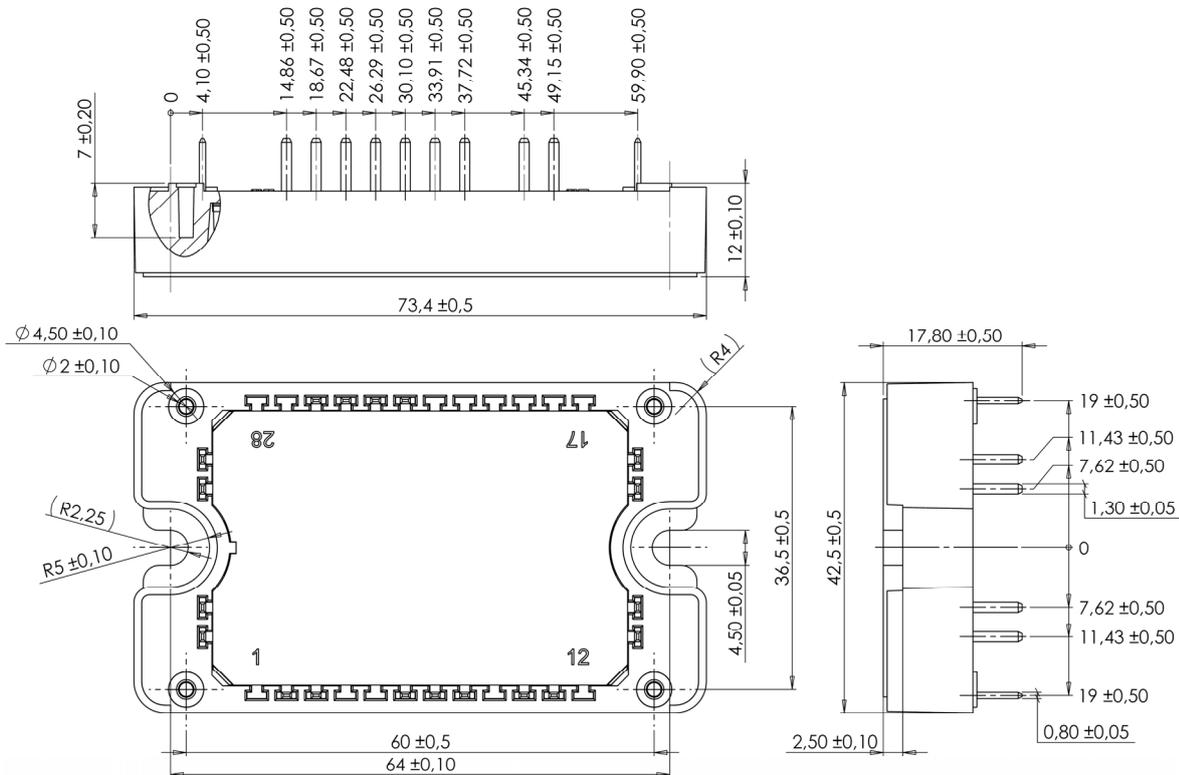
$$R_T = \frac{R_{25}}{\exp\left[B_{25/100}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature
 R_T: Thermistor value at T

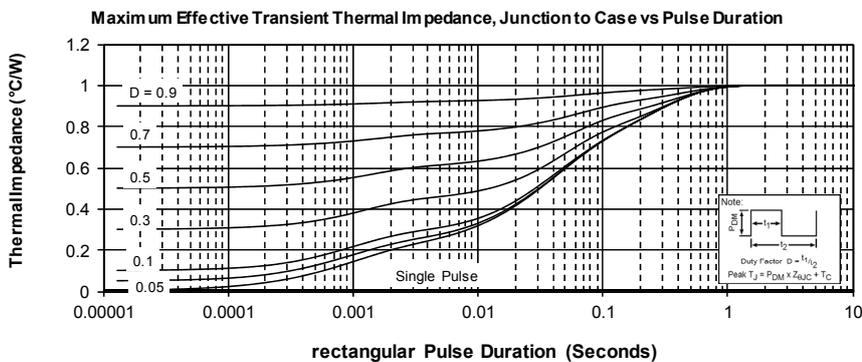
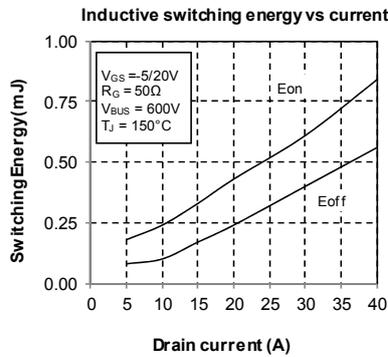
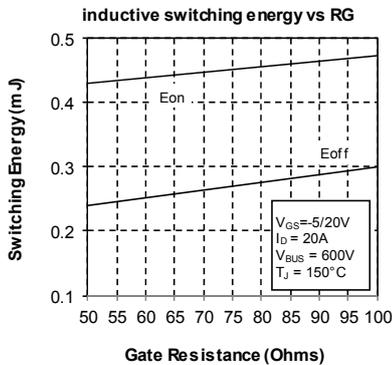
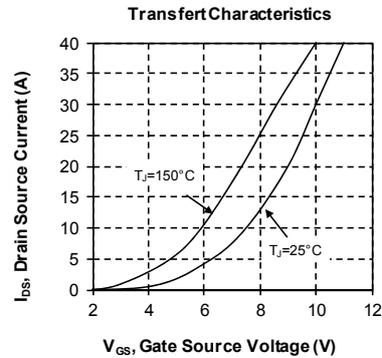
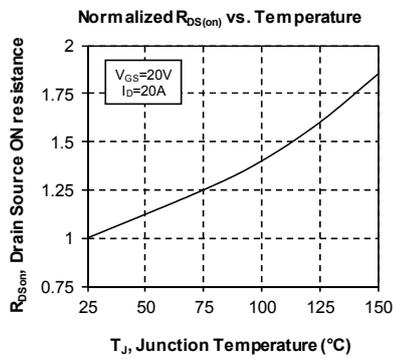
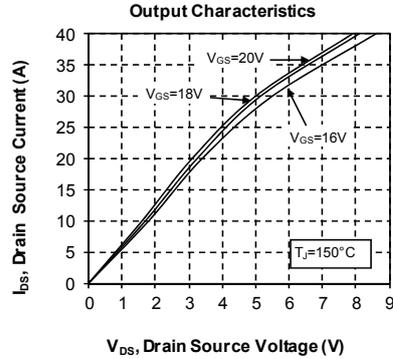
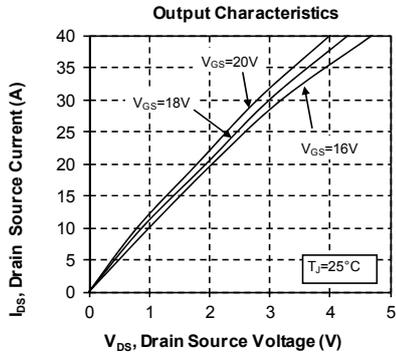
5. Thermal and package characteristics

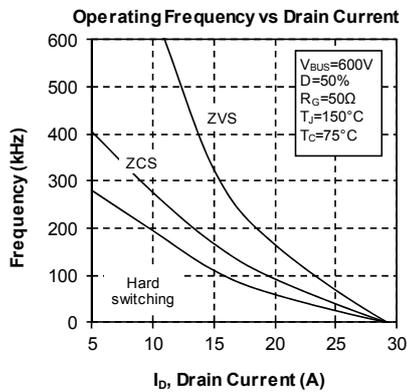
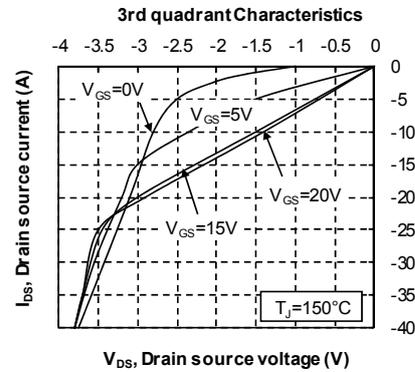
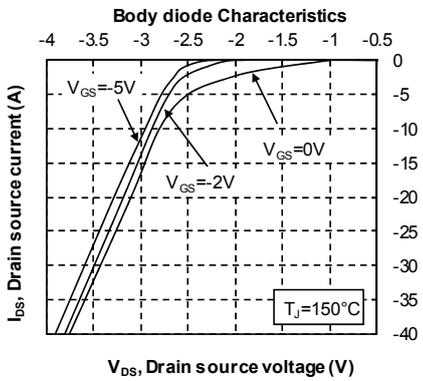
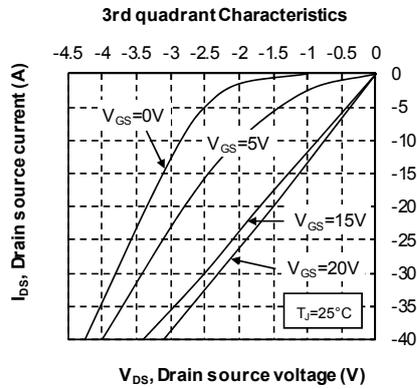
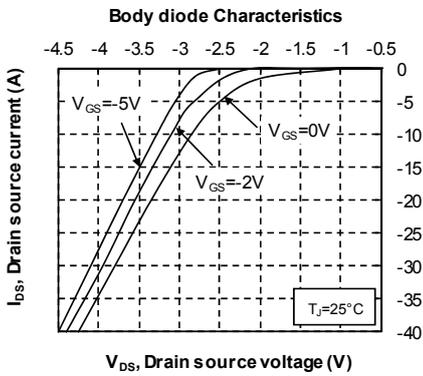
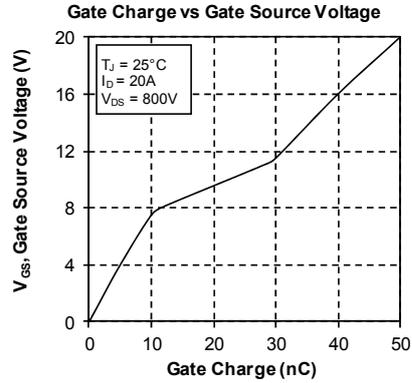
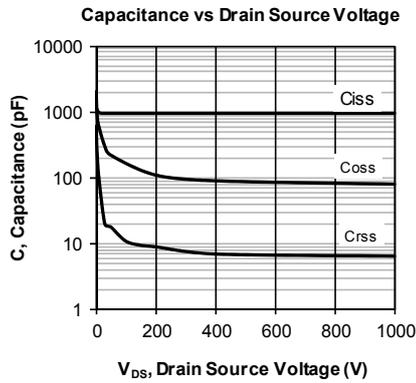
Symbol	Characteristic	Min	Max	Unit		
V _{ISOL}	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000		V		
T _J	Operating junction temperature range	SiC MOSFET	-40	150	°C	
		SiC diodes + IGBT	-40	175		
T _{JOP}	Recommended junction temperature under switching conditions	-40	T _{Jmax} -25			
T _{STG}	Storage Temperature Range	-40	125			
T _C	Operating Case Temperature	-40	125			
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

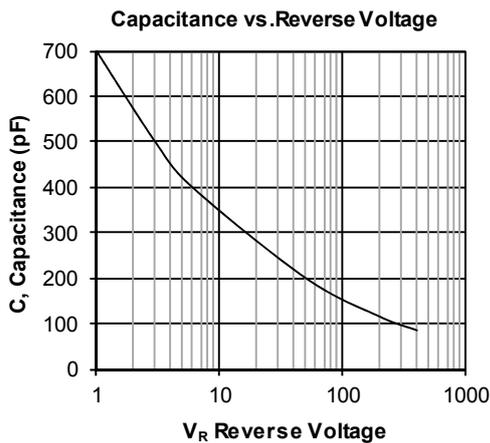
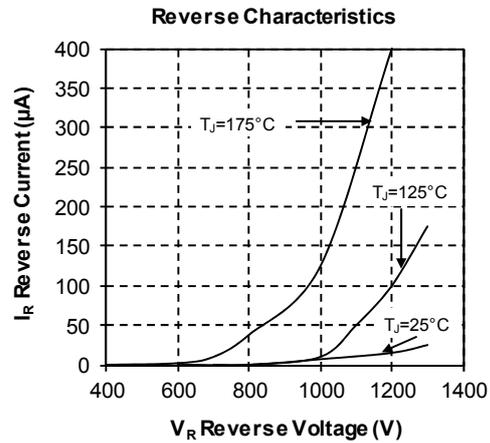
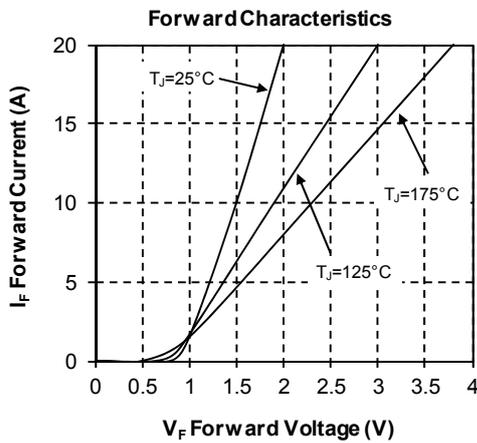
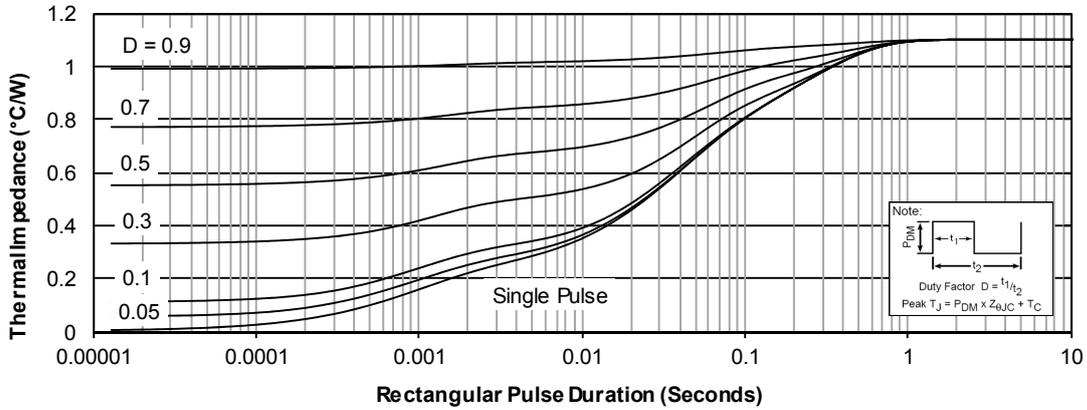
Package outline (dimensions in mm)



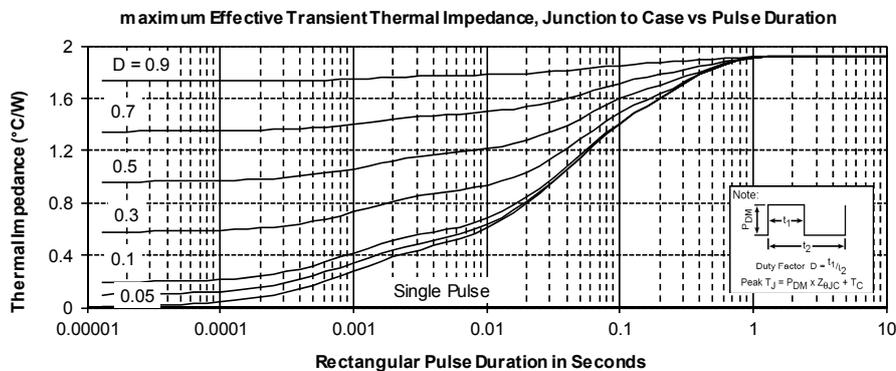
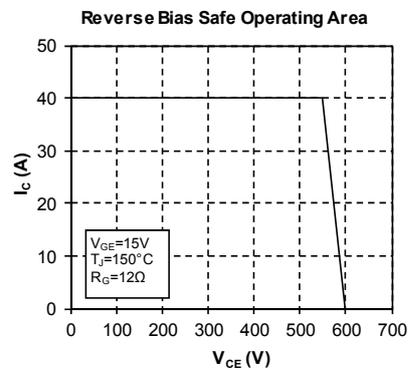
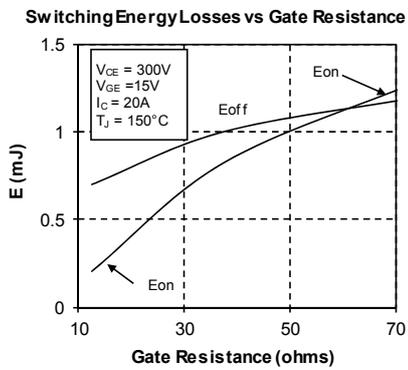
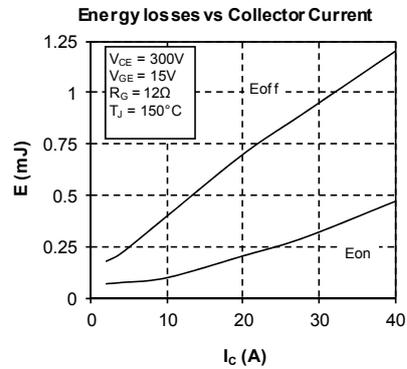
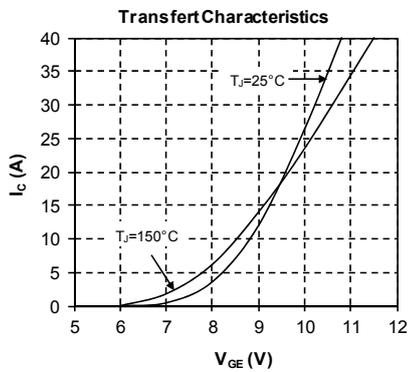
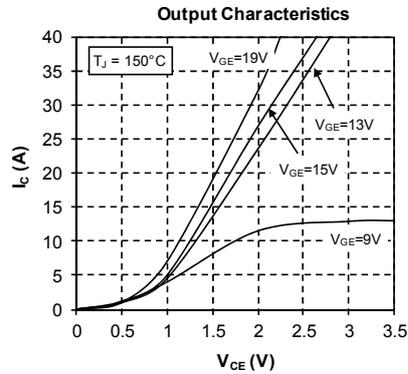
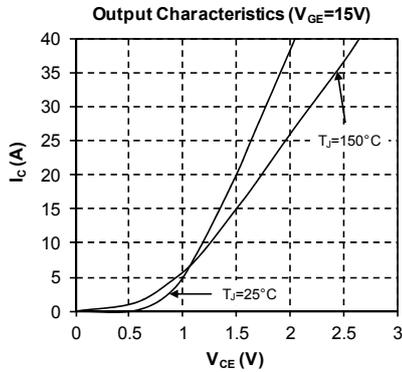
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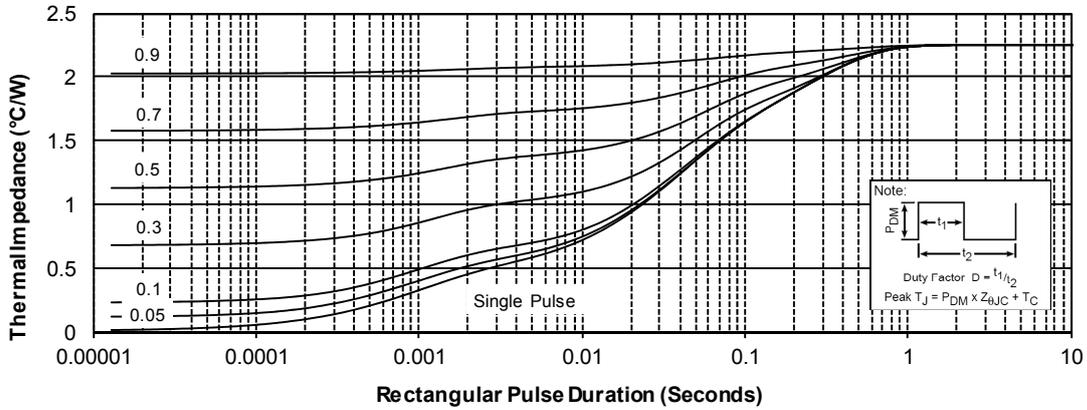
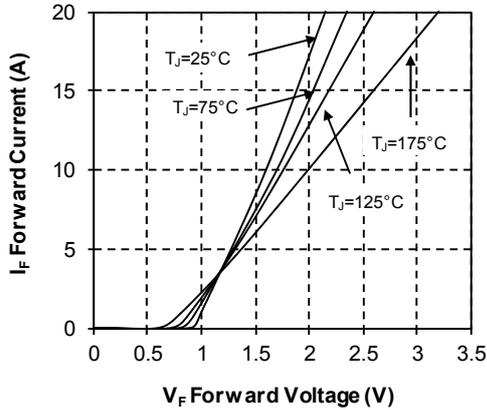
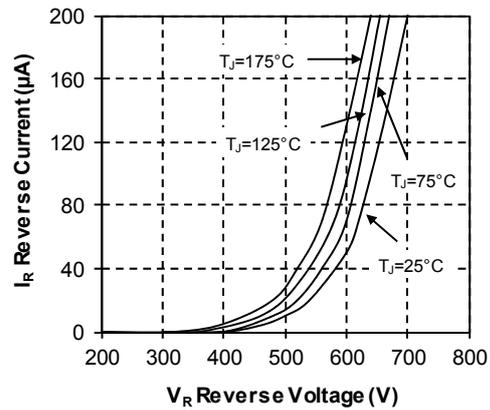
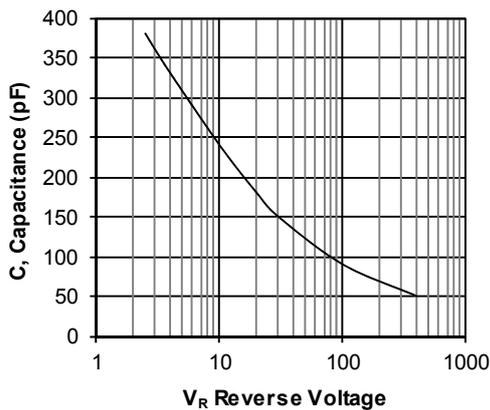
6. Typical performance curve
Q1, Q2 SiC MOSFET




CR1 & CR2 SiC diode characteristics
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration


Q3, Q4 Trench + field stop IGBT3



CR3 & CR4 SiC diode characteristics
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration

Forward Characteristics

Reverse Characteristics

Capacitance vs. Reverse Voltage


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